

# Product Change Notification - CSI0500064 - JAON-08AHID607

Date:

25 Mar 2019

**Product Category:** 

Power Management - Power Switches

Affected CPNs:



## **Notification subject:**

CCB 1737.10 Final Notice: Release to production of listed Micrel Power Switch product type manufactured with the CSI05 process technology to Microchip Fab.

#### **Notification text:**

#### **PCN Status:**

**Final Notification** 

Note: This final PCN only pertains to the products listed in this PCN. Additional final PCNs may be issued for this combination of product type and process technology.

# **PCN Type:**

Manufacturing Change

# **Microchip Parts Affected:**

Please open one of the icons found in the Affected CPNs section above.

NOTE: For your convenience Microchip includes identical files in two formats (.pdf and .xls).

# **Description of Change:**

Release to of listed Micrel Power Switch product type manufactured with the CSI05 process technology to Microchip Fab.

NOTE: Please review the FAQ linked here for additional information about this change.

# **Pre Change:**

Fabricated at Micrel fabrication site (San Jose, CA, USA) using wafers.

#### **Post Change:**

Fabricated at Microchip fabrication site using wafers.

# **Pre and Post Change Summary:**

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	Pre Change	Post Change
	Micrel fabrication site	
Fab Site		Microchip fabrication site
	(San Jose, CA, USA)	
Wafer Size	wafers	wafers

# Impacts to Data Sheet:

None

# **Reason for Change:**

To improve productivity with the closure of the Micrel fab as part of the integration of Micrel and Microchip.

#### **Change Implementation Status:**

In Progress

# **Estimated First Ship Date:**

Estimated First Ship Date (EFSD) are identified for each catalog part numbers (CPN) listed in the attached parts list. This can be found in the attachments field below labeled as PCN # Affected CPN.

# **Summary Time Table of notable events to date:**



			201	5		->			201	6		->	ı	Mar	ch 2	2019	9	->		Ma	ay 20	19	
Workweek	36	37	38	39	40		35	36	37	38	39		9	10	11	12	13		18	19	20	21	22
Initial PCN																							
Issue Date																							
	Χ																						
CYER-																							
31JLEX869																							
Qual Report																							
Available																							
										Χ													
JAON-																							
08AHID607																							
Final PCN																							
Issue Date																							
JAON-																	Х						
08AHID607-																							
CSI0500064																							
0010000001											Н									As			
																				liste			
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Estimated																				the			
First Ship																				atta			
Date																				che			
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## Markings to Distinguish Revised from Unrevised Devices:

Traceability code and shipping label see <u>FAQ</u>.

# **Revision History:**

**September 1, 2015:** Issued initial notification as PCN number <a href="CYER-31JLEX869">CYER-31JLEX869</a>.

**September 25, 2016:** Issued intermediate notification as PCN number <u>JAON-08AHID607</u>. Attached the Qualification Report. Revised the estimated first ship date (EFSD) to inform that the EFSD will be revealed in the final PCN

**h 25, 2019:** Issued final notification as PCN number -08AHID607-CSI0500064 for listed Micrel Power Switch product manufactured with the CSI05 process technology. Provided estimated first ship date (EFSD) for each CPN listed in the attached parts list.

The change described in this PCN does not alter Micrel's or Microchip's current regulatory compliance regarding the material content of the applicable products.

#### Attachment(s):

PCN JAON-08AHID607-CSI0500064 Affected CPN.pdf PCN JAON-08AHID607-CSI0500064 Qual Report.pdf PCN JAON-08AHID607-CSI0500064 Affected CPN.xls

Please contact your local <u>Microchip sales office</u> with questions or concerns regarding this notification.



#### **Terms and Conditions:**

If you wish to <u>receive Microchip PCNs via email</u> please register for our PCN email service at our <u>PCN home page</u> select register then fill in the required fields. You will find instructions about registering for Microchips PCN email service in the <u>PCN FAQ</u> section.

If you wish to <u>change your PCN profile</u>, <u>including opt out</u>, please go to the <u>PCN home page</u> select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.

JAON-08AHID607 - CCB 1737.10 Final Notice: Release to production of listed Micrel Power Switch product type manufactured with the CSI05 process technology to Microchip Fab. Affected Catalog Part Numbers (CPN) MIC2555-0YML-TR MIC2555-1YML-TR

Date: Monday, March 25, 2019

JAON-08AHID607-CSI0500063 - CCB 1737.10 Final Notice: Release to production of listed Micrel Power Switch product type manufactured with the CSI05 process technology to Microchip Fab.

Affected Catalog Part Numbers (CPN)

PCN_JAON-08AHID607-CSI0500064							
CATALOG_PART_NBR Estimated First Ship Date (EFSD)							
MIC2555-0YML-TR	May 06, 2019						
MIC2555-1YML-TR	May 06, 2019						



# QUALIFICATION REPORT SUMMARY RELIABILITY LABORATORY

PCN #: JAON-08AHID607-CSI0500064

Date September 20, 2016

Qualification of Microchip 8 inch Fabrication site for Micrel products manufactured with the CSI05 Process Technology.

PART NUMBER	PACKAGE TYPE	ASSEMBLY LOCATION	FAB LOCATION	PROCESS NAME
MIC23250-S4YMT-TR	DFN22-10L	UNISEM, IPOH, MALAYSIA	MICROCHIP FAB-2 TEMPE AZ.	CSI 0.5

# **DIE QUALIFICATION RESULTS**

TEST DESCRIPTION	METHOD/CONDITIONS	DATE CODE	LOT ID.	168 HR Rej/ss	<b>500 HR</b> Rej/ss	1000 HR Rej/ss	COMMENTS
HTOL	JESD22, Method 108	1609	V216328088.100MQB	0/77	0/77	0/77	
High Temperature Operating Life Test	Ta = + 125°C	1606	V216328088.000MQJ	0/77	0/77	0/77	
operating Life 1650	Vcc = +5.5V	1606	V216328088.000MQK	0/77	0/77	0/77	

#### **ELECTROSTATIC DISCHARGE**

TEST DESCRIPTION	METHOD/CONDITIONS	DATE CODE	LOT ID.	STRESS	RESULT Rej/ss	COMMENTS
ESD-HBM  Human Body Model ATE Test @ Room +25C	R= 1500 Ohms C= 100 pF 1X +/- Voltage	1609	V216328088.100MQB	+/-2000V	0/3	Note: ESD ratings are device specific. All Products qualified on the 8" Micrel process technologies will
ESD-CDM  Charged Device Model  ATE Test @ Room +25C	JESD22-C101 1X +/- Voltage	1609	V216328088.100MQB	+/-1500V	0/3	have the same or better ESD and Latch-up performance as the 6" San Jose Products.
TEST DESCRIPTION	METHOD/CONDITIONS	DATE CODE	LOT ID.	STRESS	RESULT Rej/ss	COMMENTS
LATCH-UP	JESD-78  TA = +25°C	1609	V216328088.100MQB	I/O LU O/V LU	0/6 0/6	

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TEST DESCRIPTION	METHOD/CONDITIONS	DATE CODE	LOT ID.	Rej/ss	COMMENTS
		1609	V216328088.100MQB	0/323	
Level 1 Pre-conditioning Flow	JESD22-A113	1606	V216328088.000MQJ	0/143	
		1606	V216328088.000MQK	0/143	
TEST DESCRIPTION	METHOD/CONDITIONS	DATE CODE	LOT ID.	96 HR Rej/ss	COMMENTS
PRESSURE POT	JESD22-A102	1609	V216328088.100MQB	0/45	
With Level 1 Pre-	Ta = +121°C/100%RH	1606	V216328088.000MQJ	0/45	
conditioning Tpeak + 260°C 3X Reflow	15 PSIG	1606	V216328088.000MQK	0/45	
TEST DESCRIPTION	METHOD/CONDITIONS	DATE CODE	LOT ID.	96 HR Rej/ss	COMMENTS
HAST	JESD22-A110 (BIASED)	1609	V216328088.100MQB	0/45	
With Level 1 Pre- conditioning	Ta= +130°C/85%RH	1606	V216328088.000MQJ	0/45	
Tpeak + 260°C 3X Reflow	Vcc = +5.5V	1606	V216328088.000MQK	0/45	
TEST DESCRIPTION	METHOD/CONDITIONS	DATE CODE	LOT ID.	500 CY Rej/ss	COMMENTS
TEMP CYCLE	JESD22-A104	1609	V216328088.100MQB	0/45	
With Level 1 Pre-	Ta = -65°C / +150°C	1606	V216328088.000MQJ	0/45	
conditioning Tpeak + 260°C 3X Reflow		1606	V216328088.000MQK	0/45	
TEST DESCRIPTION	METHOD/CONDITIONS	DATE CODE	LOT ID.	1000 HR Rej/ss	COMMENTS
HTSL					
High Temperature	JESD22-A103	1609	V216328088.100MQB	0/76	
Storage Life With Level 1 Pre- conditioning Tpeak + 260°C 3X Reflow	Ta = +150°C				
	UL-94V-0				lard. See the UL website on-line list of
FLAMMABILITY	Certified	material fl assembly	ammability certifications. M house and we verify the cer	icrel requires a rtifications on t	a Certificate of Compliance from the the web.